Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/531,457	YAMAMOTO ET AL.
Examiner	Art Unit

2833

Edwin A. León

		SEAR	CHED			
Cla	ss	Subclass	Date		Examiner	
43	9	630, 267, 76.1, 140 141	11/5/2005		EAL	
		64, 372				
		152-160				
	,	541.5, 67				
1	<i>y</i>	68, 135		/		<u>y</u>
,						
,						
·						

INT	INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner		
	<u> </u>	-			

SEARCH N (INCLUDING SEARC	IOTES CH STRATEGY	^)
	DATE	EXMR
,		
	•	1